



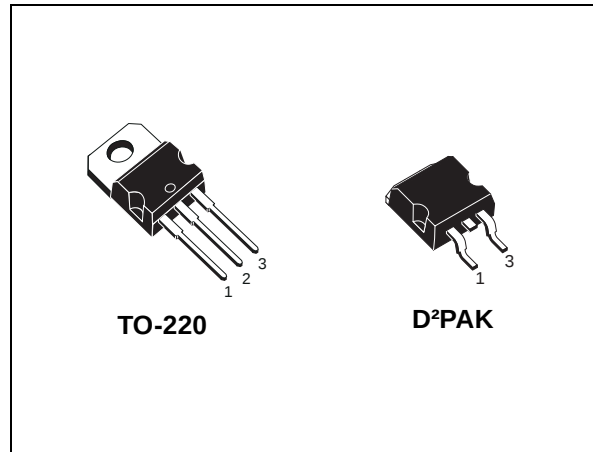
STB8NM60D STP8NM60D

N-CHANNEL 600V - 0.9Ω - 8A - TO-220/D²PAK
Fast Diode MDmesh™ Power MOSFET

General features

Type	V _{DSS}	R _{DS(on)}	I _D	P _{TOT}
STB8NM60D	600V	< 1.0Ω	8A	100W
STP8NM60D	600V	< 1.0Ω	8A	100W

- High dv/dt and avalanche capabilities
- 100% avalanche rated
- Low input capacitance and gate charge
- Low gate input resistance
- Fast internal recovery diode



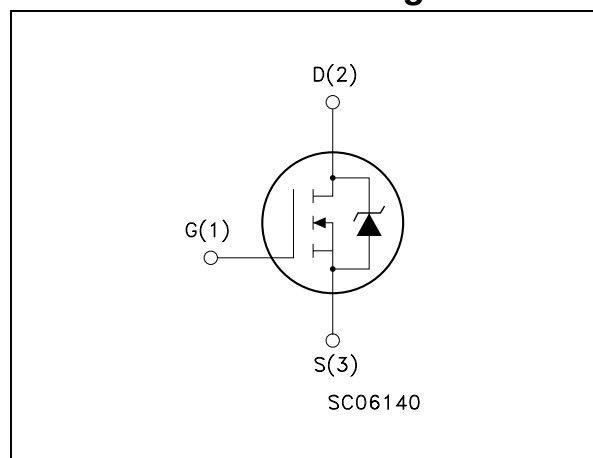
Description

The FDmesh™ associates all advantages of reduced on-resistance and fast switching with an intrinsic fast-recovery body diode. It is therefore strongly recommended for bridge topologies, in particular ZVS phase-shift converters

Applications

The MDmesh™ family is very suitable for increasing power density of high voltage converters allowing system miniaturization and higher efficiencies.

Internal schematic diagram



Order codes

Sales Type	Marking	Package	Packaging
STB8NM60D	B8NM60D	D ² PAK	TAPE & REEL
STP8NM60D	P8NM60D	TO-220	TUBE

1 Electrical ratings

Table 1. Absolute maximum ratings

Symbol	Parameter	Value	Unit
V_{DS}	Drain-Source Voltage ($V_{GS} = 0$)	600	V
V_{DGR}	Drain-gate Voltage ($R_{GS} = 20k\Omega$)	600	V
V_{GS}	Gate-Source Voltage	± 30	V
I_D	Drain Current (continuous) at $T_C = 25^\circ C$	8	A
I_D	Drain Current (continuous) at $T_C = 100^\circ C$	5	A
$I_{DM}^{(1)}$	Drain Current (pulsed)	32	A
P_{TOT}	Total Dissipation at $T_C = 25^\circ C$	100	W
	Derating Factor	0.8	W/ $^\circ C$
$dv/dt^{(2)}$	Peak Diode Recovery voltage slope	20	V/ns
T_J T_{stg}	Operating Junction Temperature Storage Temperature	-65 to 150	$^\circ C$

1. Pulse width limited by safe operating area

2. $I_{SD} \leq 5A$, $di/dt \leq 400A/\mu s$, $V_{DD} = 80\% V_{(BR)DSS}$

Table 2. Thermal data

Symbol	Parameter	Value	Unit
$R_{thj-case}$	Thermal resistance junction-case Max	1.25	$^\circ C/W$
$R_{thj-amb}$	Thermal resistance junction-ambient Max	62.5	$^\circ C/W$
T_l	Maximum lead temperature for soldering purpose	300	$^\circ C$

Table 3. Avalanche data

Symbol	Parameter	Value	Unit
I_{AR}	Avalanche current, repetitive or not repetitive (pulse width limited by T_{jmax})	2.5	A
E_{AS}	Single pulse avalanche energy (starting $T_J = 25^\circ C$, $I_D = I_{AR}$, $V_{DD} = 50V$)	200	mJ

2 Electrical characteristics

($T_{CASE}=25^{\circ}\text{C}$ unless otherwise specified)

Table 4. On/off states

Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Unit
$V_{(BR)DSS}$	Drain-Source Breakdown Voltage	$I_D = 250\mu\text{A}$, $V_{GS} = 0$	600			V
I_{DSS}	Zero Gate Voltage Drain Current ($V_{GS} = 0$)	$V_{DS} = \text{Max Rating}$, $V_{DS} = \text{Max Rating}$, $T_c=125^{\circ}\text{C}$			1 10	μA μA
I_{GSS}	Gate Body Leakage Current ($V_{DS} = 0$)	$V_{GS} = \pm 30\text{V}$, $V_{DS} = 0$			± 100	nA
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS} = V_{GS}$, $I_D = 250\mu\text{A}$	3	4	5	V
$R_{DS(on)}$	Static Drain-Source On Resistance	$V_{GS} = 10\text{V}$, $I_D = 2.5\text{A}$		0.9	1	Ω

Table 5. Dynamic

Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Unit
$g_{fs}^{(1)}$	Forward Transconductance	$V_{DS} = I_{D(on)} \times R_{DS(on)max}$ $I_D = 2.5\text{A}$		2.4		S
C_{iss} C_{oss} C_{rss}	Input Capacitance Output Capacitance Reverse Transfer Capacitance	$V_{DS} = 25\text{V}$, $f = 1\text{ MHz}$, $V_{GS} = 0$		380 170 14		pF pF pF
$C_{oss\ eq.}^{(2)}$	Equivalent Output Capacitance	$V_{GS} = 0$, $V_{DS} = 0\text{V to } 480\text{V}$		60		pF
Q_g Q_{gs} Q_{gd}	Total Gate Charge Gate-Source Charge Gate-Drain Charge	$V_{DD} = 400\text{V}$, $I_D = 5\text{A}$ $V_{GS} = 10\text{V}$ (see Figure 13)		15 4 8	18	nC nC nC

1. Pulsed: pulse duration=300 μs , duty cycle 1.5%

2. $C_{oss\ eq.}$ is defined as a constant equivalent capacitance giving the same charging time as C_{oss} when V_{DS} increases from 0 to 80% V_{DSS}

Table 6. Switching times

Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Unit
$t_{d(on)}$	Turn-on Delay Time	$V_{DD}=300V$, $I_D=2.5A$, $R_G=4.7\Omega$, $V_{GS}=10V$ (see Figure 12)		13		ns
t_r	Rise Time			10		ns
$t_{d(off)}$	Turn-off Delay Time			26		ns
t_f	Fall Time			8		ns
$t_{d(off)}$	Turn-off Delay Time	$V_{DD}=480V$, $I_D=5A$, $R_G=4.7\Omega$, $V_{GS}=10V$ (see Figure 12)		8		ns
t_f	Fall Time			8		ns
t_c	Cross-over Time			14		ns

Table 7. Source drain diode

Symbol	Parameter	Test Conditions	Min.	Typ.	Max.	Unit
I_{SD}	Source-drain Current				5	A
$I_{SDM}^{(1)}$	Source-drain Current (pulsed)				20	A
$V_{SD}^{(2)}$	Forward on Voltage	$I_{SD}=5A$, $V_{GS}=0$			1.5	V
t_{rr}	Reverse Recovery Time	$I_{SD}=5A$, $di/dt = 100A/\mu s$, $V_{DD}=50V$, $T_j=25^\circ C$		107		ns
Q_{rr}	Reverse Recovery Charge			330		nC
I_{RRM}	Reverse Recovery Current			6		A
t_{rr}	Reverse Recovery Time	$I_{SD}=5A$, $di/dt = 100A/\mu s$, $V_{DD}=50V$, $T_j=150^\circ C$		178		ns
Q_{rr}	Reverse Recovery Charge			640		nC
I_{RRM}	Reverse Recovery Current			7		A

1. Pulse width limited by safe operating area

2. Pulsed: pulse duration=300 μs , duty cycle 1.5%

2.1 Electrical characteristics (curves)

Figure 1. Safe operating area

Figure 2. Thermal impedance

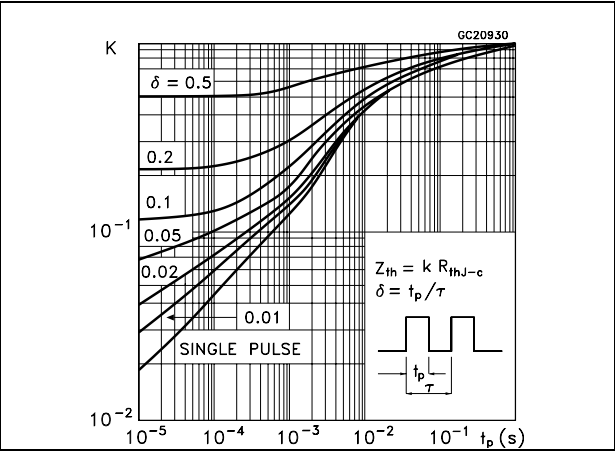
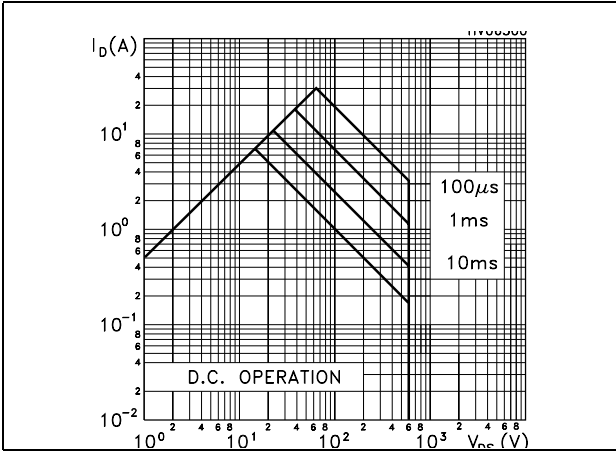


Figure 3. Output characteristics

Figure 4. Transfer characteristics

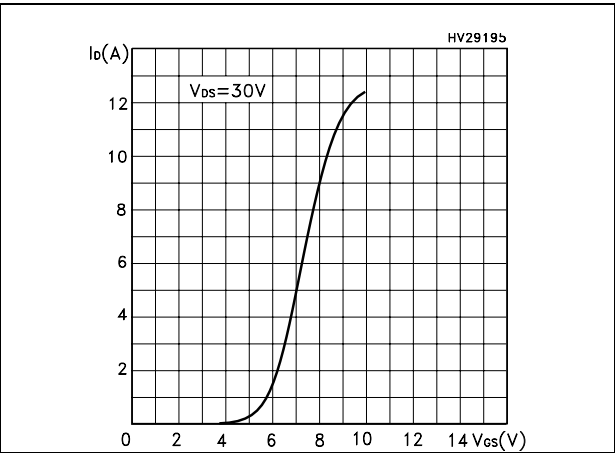
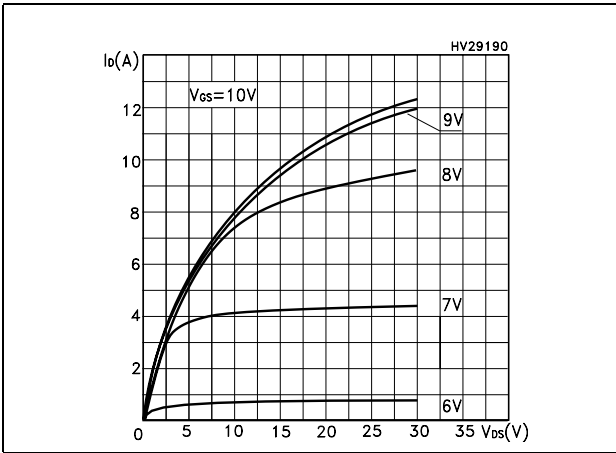


Figure 5. Transconductance

Figure 6. Static drain-source on resistance

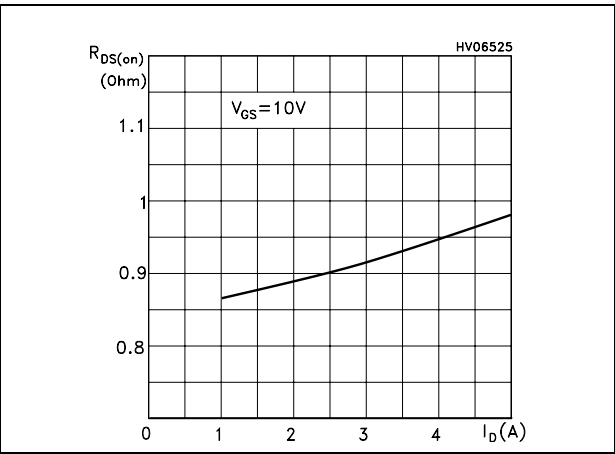
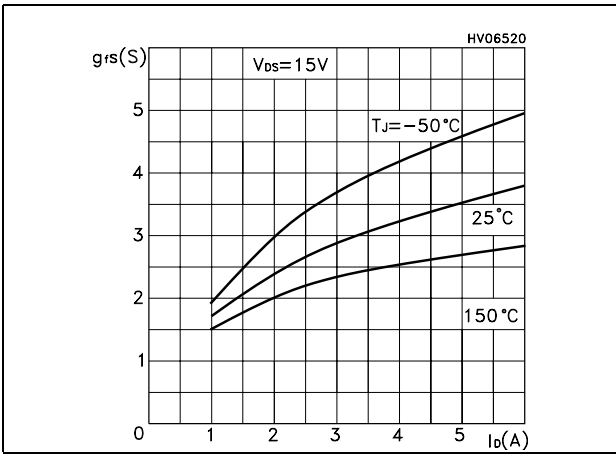


Figure 7. Gate charge vs gate-source voltage Figure 8. Capacitance variations

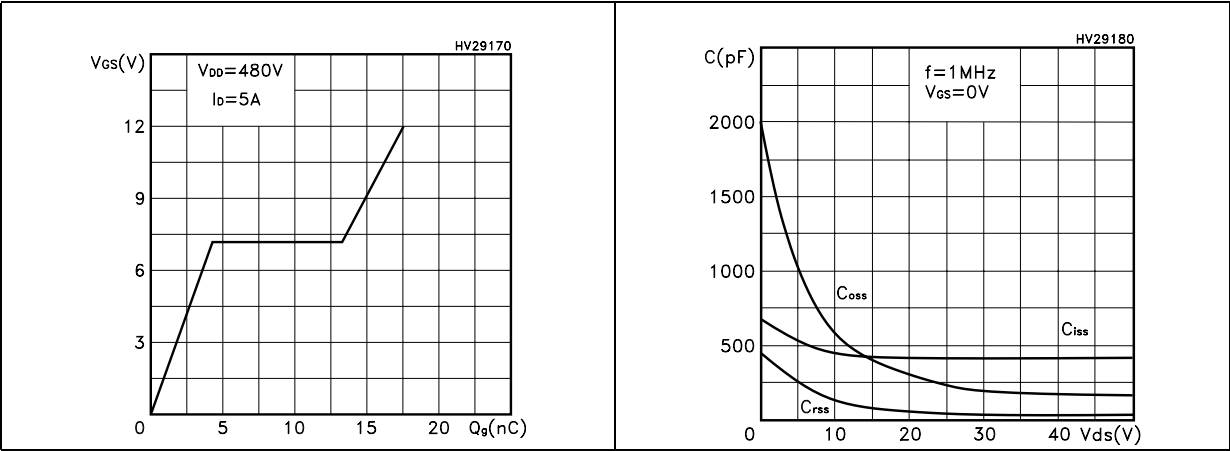


Figure 9. Normalized gate threshold voltage vs temperature Figure 10. Normalized on resistance vs temperature

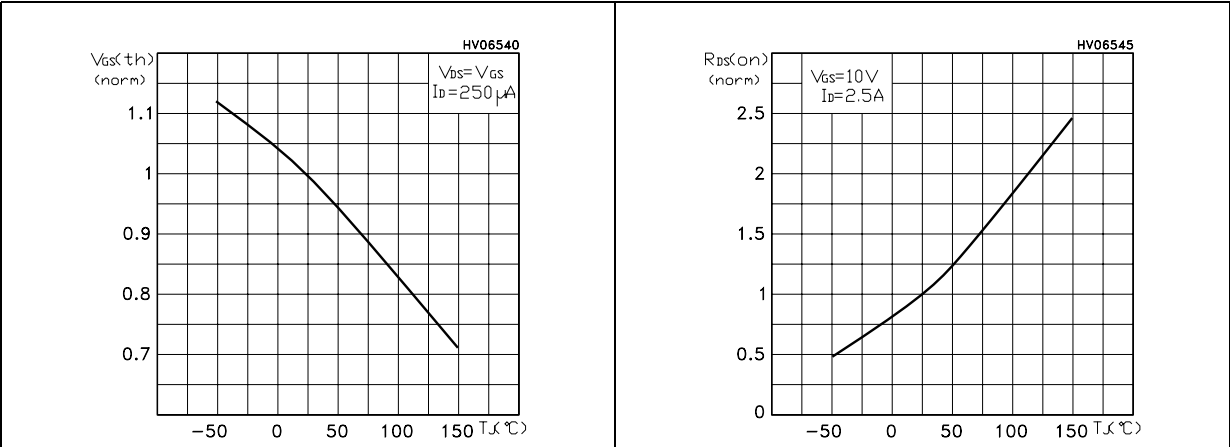
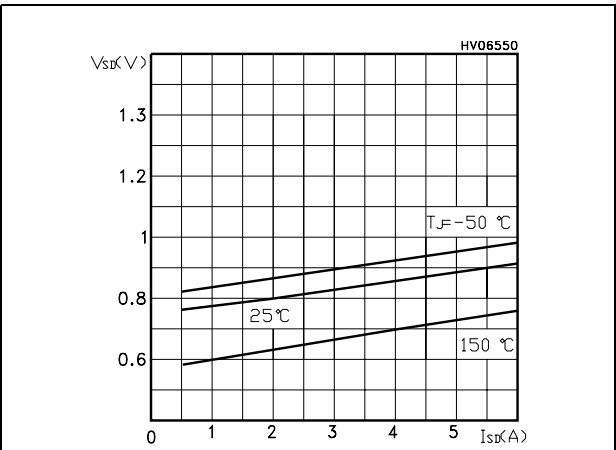


Figure 11. Source-drain diode forward characteristics



3 Test circuit

Figure 12. Switching times test circuit for resistive load

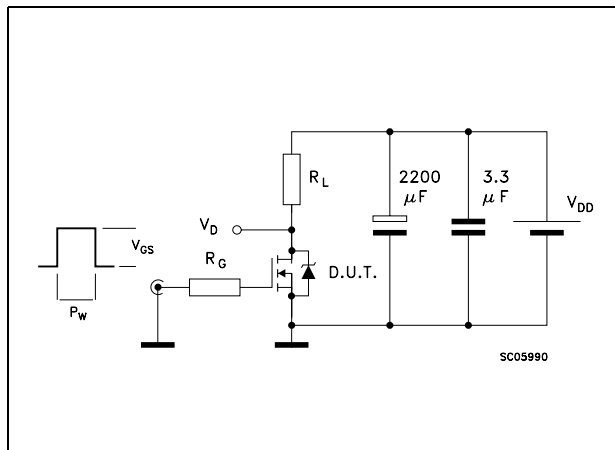


Figure 13. Gate charge test circuit

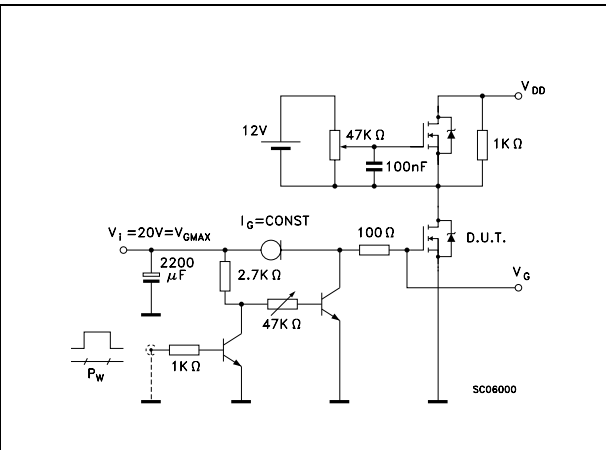


Figure 14. Test circuit for inductive load switching and diode recovery times

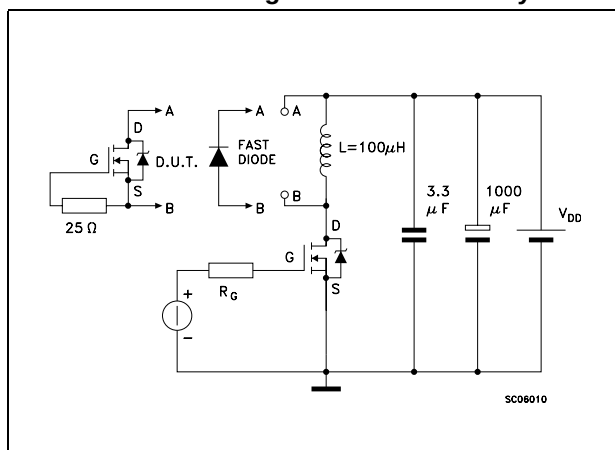


Figure 15. Unclamped Inductive load test circuit

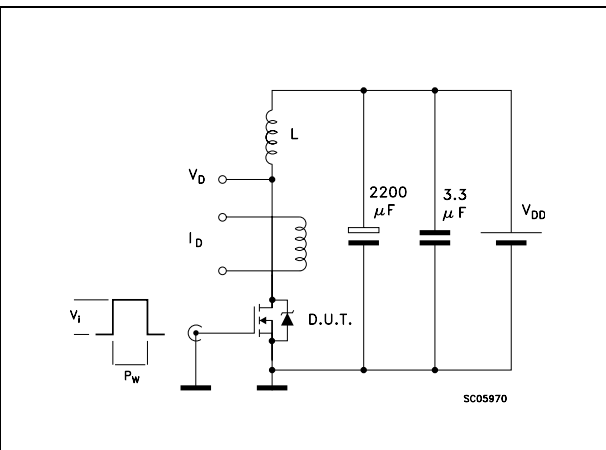


Figure 16. Unclamped inductive waveform

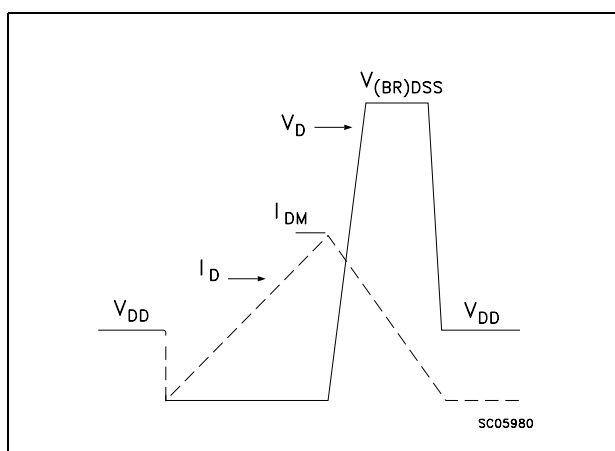
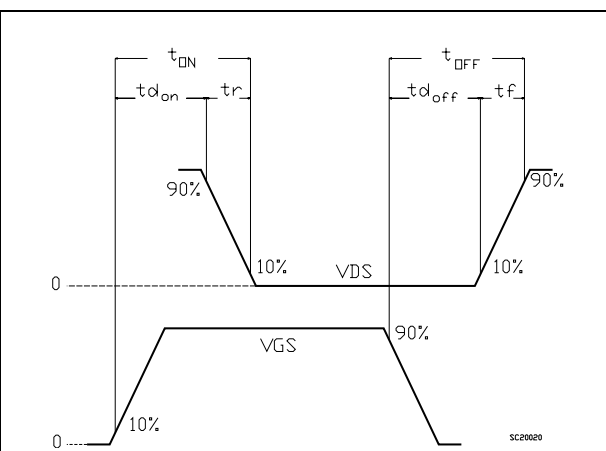


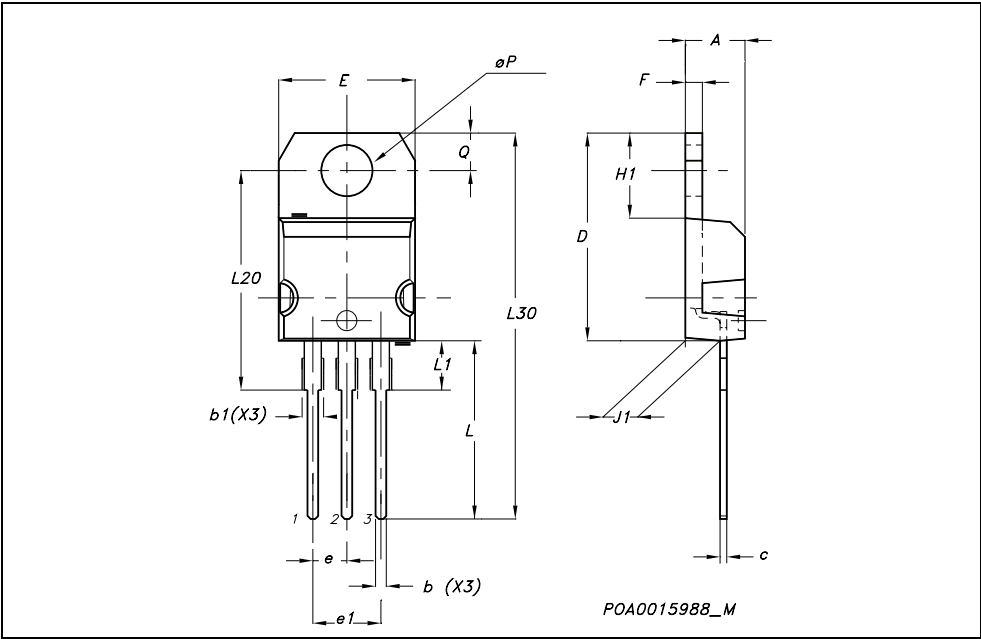
Figure 17. Switching time waveform



4 Package mechanical data

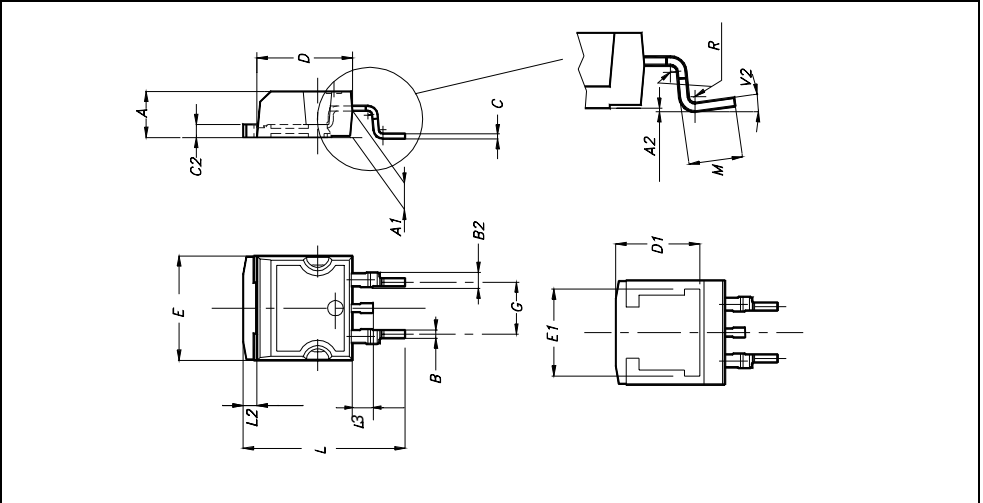
In order to meet environmental requirements, ST offers these devices in ECOPACK® packages. These packages have a Lead-free second level interconnect . The category of second level interconnect is marked on the package and on the inner box label, in compliance with JEDEC Standard JESD97. The maximum ratings related to soldering conditions are also marked on the inner box label. ECOPACK is an ST trademark. ECOPACK specifications are available at: www.st.com

TO-220 MECHANICAL DATA						
DIM.	mm.			inch		
	MIN.	TYP.	MAX.	MIN.	TYP.	MAX.
A	4.40		4.60	0.173		0.181
b	0.61		0.88	0.024		0.034
b1	1.15		1.70	0.045		0.066
c	0.49		0.70	0.019		0.027
D	15.25		15.75	0.60		0.620
E	10		10.40	0.393		0.409
e	2.40		2.70	0.094		0.106
e1	4.95		5.15	0.194		0.202
F	1.23		1.32	0.048		0.052
H1	6.20		6.60	0.244		0.256
J1	2.40		2.72	0.094		0.107
L	13		14	0.511		0.551
L1	3.50		3.93	0.137		0.154
L20		16.40			0.645	
L30		28.90			1.137	
øP	3.75		3.85	0.147		0.151
Q	2.65		2.95	0.104		0.116



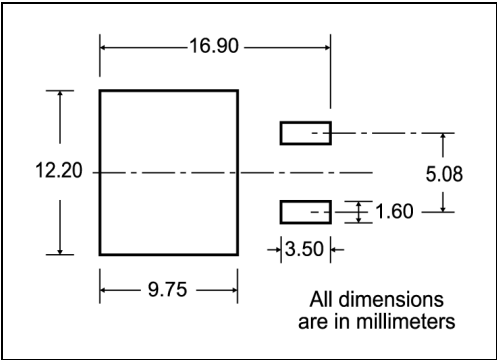
D²PAK MECHANICAL DATA

DIM.	mm.			inch		
	MIN.	TYP	MAX.	MIN.	TYP.	MAX.
A	4.4		4.6	0.173		0.181
A1	2.49		2.69	0.098		0.106
A2	0.03		0.23	0.001		0.009
B	0.7		0.93	0.027		0.036
B2	1.14		1.7	0.044		0.067
C	0.45		0.6	0.017		0.023
C2	1.23		1.36	0.048		0.053
D	8.95		9.35	0.352		0.368
D1		8			0.315	
E	10		10.4	0.393		
E1		8.5			0.334	
G	4.88		5.28	0.192		0.208
L	15		15.85	0.590		0.625
L2	1.27		1.4	0.050		0.055
L3	1.4		1.75	0.055		0.068
M	2.4		3.2	0.094		0.126
R		0.4			0.015	
V2	0°		4°			

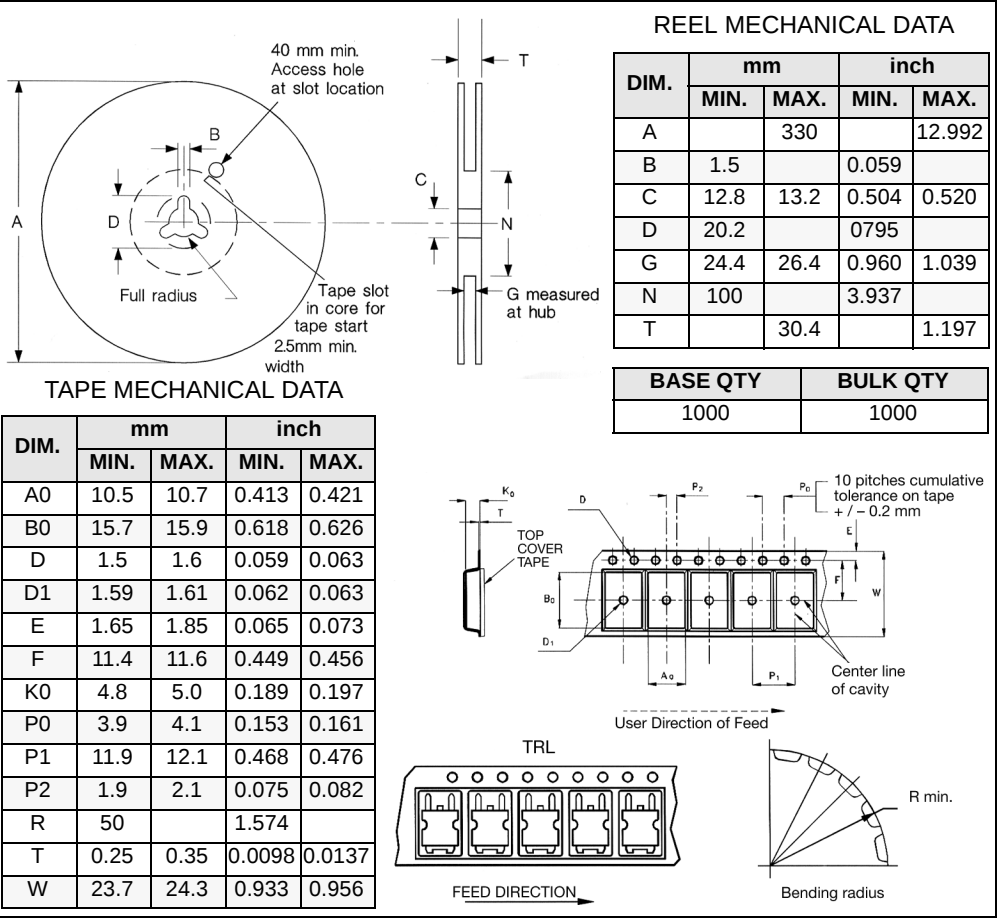


5 Packaging mechanical data

D²PAK FOOTPRINT



TAPE AND REEL SHIPMENT



* on sales type

6 Revision history

Table 8. Document revision history

Date	Revision	Changes
13-Jan-2006	1	Initial release.
15-Feb-2006	2	Modified Description on first page

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